

Rohs

## WFF840B-VB Datasheet N-Channel 650V (D-S) Power MOSFET

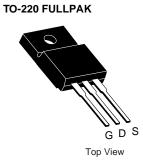
PRODUCT SUMMA	RY	
V <sub>DS</sub> (V) at T <sub>J</sub> max.	650	)
R <sub>DS(on)</sub> at 25 °C (Ω)	$V_{GS} = 10 V$	0.65
Q <sub>g</sub> max. (nC)	43	
Q <sub>gs</sub> (nC)	5	
Q <sub>gd</sub> (nC)	22	
Configuration	Sing	le

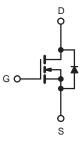
### **FEATURES**

- Low figure-of-merit (FOM) Ron x Qg
- Low input capacitance (Ciss)
- · Reduced switching and conduction losses
- Ultra low gate charge (Q<sub>q</sub>)
- Avalanche energy rated (UIS)

### **APPLICATIONS**

- · Server and telecom power supplies
- Switch mode power supplies (SMPS)
- Power factor correction power supplies (PFC)
- Lighting
  - High-intensity discharge (HID)
  - Fluorescent ballast lighting
- Industrial





N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS (T <sub>C</sub> :	= 25 °C, unl	ess otherwis	se noted)		
PARAMETER		SYMBOL	LIMIT	UNIT	
Drain-Source Voltage		V <sub>DS</sub>	650	v	
Gate-Source Voltage		V <sub>GS</sub>	± 30	v	
Continuous Drain Current (T. 150 °C)	V at 10 V	T <sub>C</sub> = 25 °C	1	12	
Continuous Drain Current (T <sub>J</sub> = 150 °C)	V <sub>GS</sub> at 10 V	T <sub>C</sub> = 25 °C T <sub>C</sub> = 100 °C	I <sub>D</sub>	9.4	А
Pulsed Drain Current <sup>a</sup>	•		I <sub>DM</sub>	45	
Linear Derating Factor				3.6	W/°C
Single Pulse Avalanche Energy <sup>b</sup>		E <sub>AS</sub>	290	mJ	
Maximum Power Dissipation		PD	106 /34	W	
Operating Junction and Storage Temperature Range	Э		T <sub>J</sub> , T <sub>stg</sub>	-55 to +150	°C
Drain-Source Voltage Slope	T <sub>J</sub> = 1	25 °C	-1) ( / -14	15	
Reverse Diode dV/dt <sup>d</sup>	iode dV/dt <sup>d</sup>		dV/dt	4.1	V/ns
Soldering Recommendations (Peak Temperature) <sup>c</sup>	for	10 s		300	°C

#### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature. b.  $V_{DD} = 50 \text{ V}$ , starting  $T_J = 25 \text{ °C}$ , L = 28.2 mH, R<sub>g</sub> = 25  $\Omega$ , I<sub>AS</sub> = 4.5 A.

c. 1.6 mm from case.

d.  $I_{SD} \leq I_D$ , dI/dt = 100 A/µs, starting  $T_J$  = 25 °C.



THERMAL RESISTANCE RATI	NGS								
PARAMETER	SYMBOL	TYP.		MAX.		UNIT			
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-		60			0 <b>0</b> 00		
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	- 0.8				°C/W			
<b>SPECIFICATIONS</b> ( $T_J = 25 \text{ °C}$ , u		se noted)			I	1	I		
PARAMETER	SYMBOL	TES	r condit	IONS	MIN.	TYP.	MAX.	UNIT	
Static									
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub> =	= 0 V, I <sub>D</sub> =	250 µA	650	-	-	V	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	e to 25 °C,	I <sub>D</sub> = 1 mA	-	0.75	-	V/°C	
Gate-Source Threshold Voltage (N)	V <sub>GS(th)</sub>	V <sub>DS</sub> =	= V <sub>GS</sub> , I <sub>D</sub> =	250 µA	3	-	5	V	
Cata Sauraa Laakaaa	1	$V_{GS} = \pm 20 V$ $V_{GS} = \pm 30 V$		-	-	± 100	nA		
Gate-Source Leakage	I <sub>GSS</sub>			-	-	± 1	μA		
		V <sub>DS</sub> =	= 650 V, V <sub>G</sub>	<sub>iS</sub> = 0 V	-	-	1		
Zero Gate Voltage Drain Current	IDSS	V <sub>DS</sub> = 520 V	$V_{DS} = 520 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, \text{ T}_{J} = 125 \text{ °C}$		-	-	10	μΑ	
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	$V_{GS} = 10 V$		I <sub>D</sub> = 8 A	-	0.65	-	Ω	
Forward Transconductance	<b>g</b> fs	V <sub>DS</sub>	= 30 V, $I_D$	= 8 A	-	16	-	S	
Dynamic					•				
Input Capacitance	C <sub>iss</sub>		V <sub>GS</sub> = 0 V,		-	1600	-		
Output Capacitance	C <sub>oss</sub>		$V_{DS} = 100$	V,	-	300	-		
Reverse Transfer Capacitance	C <sub>rss</sub>	f = 1 MHz		-	200	-	_		
Effective Output Capacitance, Energy Related <sup>a</sup>	C <sub>o(er)</sub>	V – 0)	′ to 520 V,	V – 0 V	-	63	-	pF	
Effective Output Capacitance, Time Related <sup>b</sup>	C <sub>o(tr)</sub>	v <sub>DS</sub> = 0 v	10 520 V,	v <sub>GS</sub> = 0 v	-	213	-		
Total Gate Charge	Qg				-	43	96		
Gate-Source Charge	Q <sub>gs</sub>	$V_{GS} = 10 V$	I <sub>D</sub> = 8 /	A, V <sub>DS</sub> = 520 V	-	5	-	nC	
Gate-Drain Charge	Q <sub>gd</sub>				-	22	-		
Turn-On Delay Time	t <sub>d(on)</sub>				-	13	25		
Rise Time	t <sub>r</sub>	$V_{DD}$ = 520 V, I_D = 8 A, $V_{GS}$ = 10 V, R_g = 9.1 $\Omega$		-	11	35	ns		
Turn-Off Delay Time	t <sub>d(off)</sub>			-	81	90			
Fall Time	t <sub>f</sub>				-	25	40		
Gate Input Resistance	Rg	f = 1	MHz, ope	n drain	-	3.5	-	Ω	
Drain-Source Body Diode Characteristic	s								
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET syml showing the	loc		-	-	15	•	
Pulsed Diode Forward Current	I <sub>SM</sub>	integral revers p - n junction			-	-	40	A	
Diode Forward Voltage	V <sub>SD</sub>	T <sub>J</sub> = 25 °	C, I <sub>S</sub> = 8 A	, V <sub>GS</sub> = 0 V	-	-	1.5	V	
Reverse Recovery Time	t <sub>rr</sub>				-	345	-	ns	
Reverse Recovery Charge	Q <sub>rr</sub>	$T_J = 2$	5 °C, I <sub>F</sub> =	<sub>S</sub> = 8 A,	_	4.5	-	μC	
Reverse Recovery Current	I <sub>RRM</sub>	ai/at = 1	00 A/μs, \	r <sub>R</sub> = 400 V	-	35	-	A	

### Notes

a.  $C_{oss(er)}$  is a fixed capacitance that gives the same energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DSS}$ . b.  $C_{oss(tr)}$  is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DSS}$ .



### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

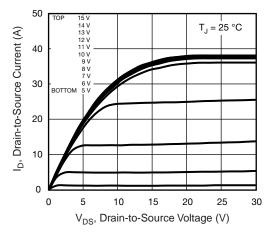


Fig. 1 - Typical Output Characteristics

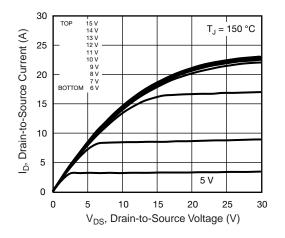


Fig. 2 - Typical Output Characteristics

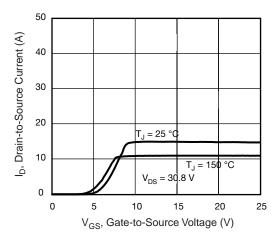


Fig. 3 - Typical Transfer Characteristics

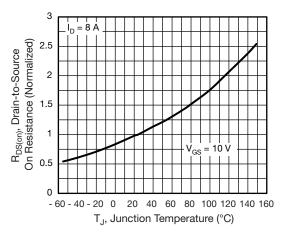


Fig. 4 - Normalized On-Resistance vs. Temperature

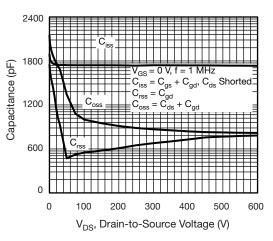


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

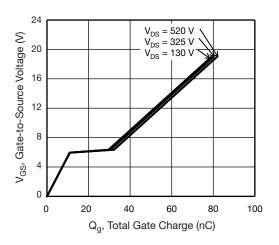


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

### WFF840B-VB



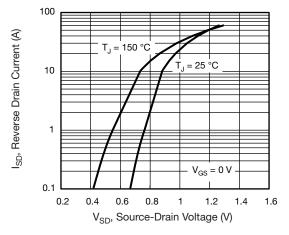
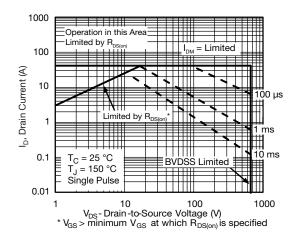


Fig. 7 - Typical Source-Drain Diode Forward Voltage





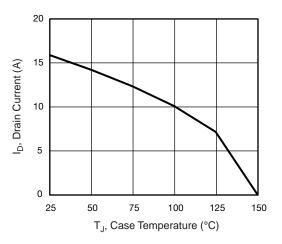


Fig. 9 - Maximum Drain Current vs. Case Temperature

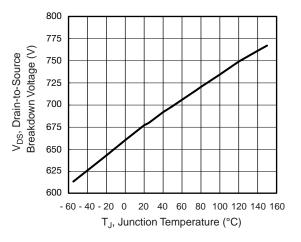


Fig. 10 - Temperature vs. Drain-to-Source Voltage

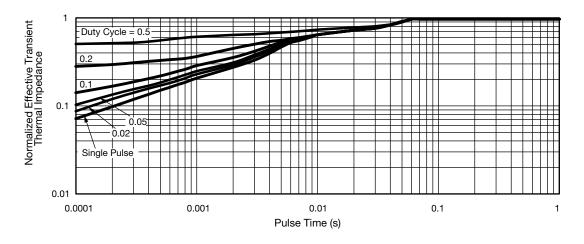


Fig. 11 - Normalized Thermal Transient Impedance, Junction-to-Case



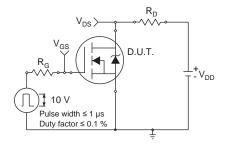


Fig. 12 - Switching Time Test Circuit

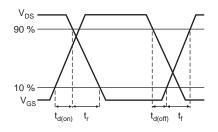


Fig. 13 - Switching Time Waveforms

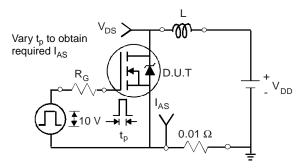


Fig. 14 - Unclamped Inductive Test Circuit

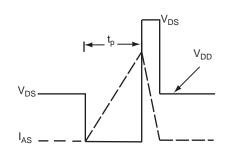


Fig. 15 - Unclamped Inductive Waveforms

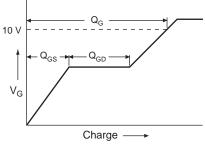


Fig. 16 - Basic Gate Charge Waveform

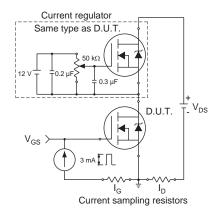
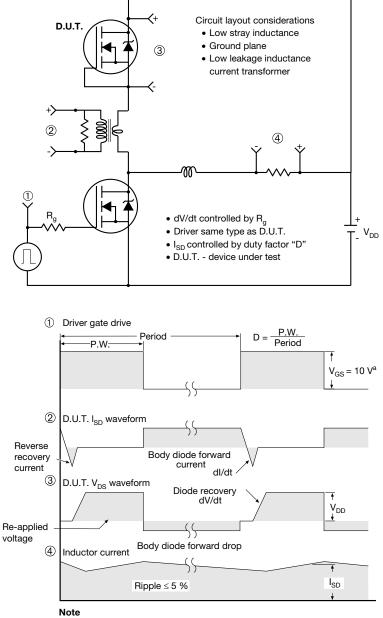


Fig. 17 - Gate Charge Test Circuit



### Peak Diode Recovery dV/dt Test Circuit

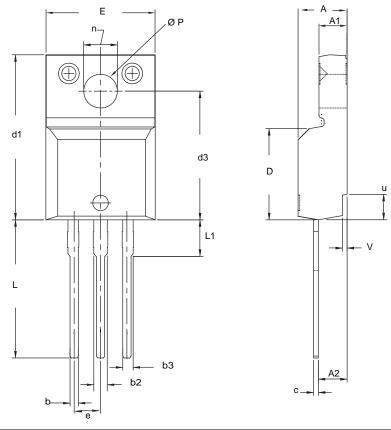


a.  $V_{GS} = 5$  V for logic level devices

Fig. 18 - For N-Channel



### **TO-220 FULLPAK (HIGH VOLTAGE)**



DIM.	MILLIN	METERS	INCHES		
	MIN.	MAX.	MIN.	MAX.	
А	4.570	4.830	0.180	0.190	
A1	2.570	2.830	0.101	0.111	
A2	2.510	2.850	0.099	0.112	
b	0.622	0.890	0.024	0.035	
b2	1.229	1.400	0.048	0.055	
b3	1.229	1.400	0.048	0.055	
С	0.440	0.629	0.017	0.025	
D	8.650	9.800	0.341	0.386	
d1	15.88	16.120	0.622	0.635	
d3	12.300	12.920	0.484	0.509	
E	10.360	10.630	0.408	0.419	
е	2.54	BSC	0.100 BSC		
L	13.200	13.730	0.520	0.541	
L1	3.100	3.500	0.122	0.138	
n	6.050	6.150	0.238	0.242	
ØP	3.050	3.450	0.120	0.136	
u	2.400	2.500	0.094	0.098	
V	0.400	0.500	0.016	0.020	

Notes

1. To be used only for process drawing. 2. These dimensions apply to all TO-220, FULLPAK leadframe versions 3 leads. 3. All critical dimensions should C meet  $C_{pk} > 1.33$ . 4. All dimensions include burrs and plating thickness. 5. No chipping or package damage.



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